

application of

Attn: BOX MISSING PARTS

Mamoru NAKASUJI et al.

Docket No. 2003 1217A

Serial No. 10/651,105

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Filed August 29, 2003

THE COMMISSIONER IS AUTHORIZED TO CHARGE ANY DEFICIENCY IN THE

FEES FOR THIS PAPER TO DEPOSIT

) (

ACCOUNT NO. 23-0975

ELECTRON BEAM SYSTEM

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to the provisions of 37 CFR 1.56, 1.97 and 1.98, Applicants request consideration of the references listed on attached form PTO-1449. A legible copy of each reference listed on the form PTO-1449 is enclosed.

1a. [X] This Information Disclosure Statement is submitted:

within three months of the filing date (or of entry into the National Stage) of the above-entitled application, or

before the mailing of a first Office Action on the merits or the mailing of a first Office Action after the filing of an RCE,

and thus no certification and/or fee is required.

1b. [] This Information Disclosure Statement is submitted

after the events of above paragraph 1a and prior to the mailing date of a final Office Action or a Notice of Allowance or an action which otherwise closes prosecution in the application, and thus:

	(1) []	the certification of paragraph 2 below is provided, or									
	(2) [] the fee of \$180.00 specified in 37 CFR 1.17(p) is enclosed.[] This Information Disclosure Statement is submitted:										
	after the mailing date of a final Office Action or Notice of Allowance or action who otherwise closes prosecution in the application, and prior to payment of the issue fee, at thus:										
1	the cei	rtification of paragraph 2 below is provided, and									
1	the fee	of \$180.00 specified in 37 CFR 1.17(p) is enclosed.									
Ι	t is he	reby certified									
a	ı. []	that each item of information contained in this Information Disclosure Statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the Statement, or									
b	. []	that no item of information contained in the Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application and, to the knowledge of the person signing the certification after making reasonable inquiry, was known to any individual designated in §1.56(c) more than three months prior to the filing of the Statement.									
Cab	onside oandon	ration of the following list of additional information (including any copending or ed U.S. application, prior uses and/or sales, etc.) is requested.									
Fo	or each ade to:	non-English language reference listed on the attached form PTO-1449, reference is									
a.	[]	a full or partial English language translation submitted herewith,									

lc.

2.

3. []

4.

b. []

a foreign patent office search report (in the English language) submitted herewith,

- c. [] the concise explanation contained in the specification of the present application at page,
- d. [X] the concise explanation set forth in the attached English language abstract,
- e. [X] the concise explanation is set forth below for references (AA-AC and AJ-AK):

References AB-AC and AJ discloses a defect detecting apparatus employing an image projection optical system;

Reference AA teaches a mask inspecting apparatus; and

Reference AK shows a defect detecting apparatus.

5. [] A foreign patent office search report citing one or more of the references is enclosed.

Respectfully submitted,

Mamoru NAKASUJI et al.

By

Michael S. Huppert Registration No. 40,268

Attorney for Applicants

MSH/kjf Washington, D.C. 20006-1021 Telephone (202) 721-8200 Facsimile (202) 721-8250 January 21, 2004

Sheet 1 of 1												
FORM PTO 1449 (m					SERIAL NO. 10/651,105							
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S)				APPLICANT Mamoru NAKASUJI et al.								
(Use several sheets if necessary) Date Submitted to PTO: January 21, 2004				FILING DATE August 29, 2003			GROUP					
			U.	S. PATENT DO	OCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE		NAME	СІ	ASS	SUBCLASS	FILING DA			
OIPE	AA	5,892,224	4/1999	N	akasuji							
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FOREIGN PATENT DOCUMENTS												
	DOCUMENT DATE NUMBER			C	OUNTRY	CI	CLASS SUBCLASS		TRANSLATION YES NO			
	AJ	11-132975	5/1999		JP				Abstract			
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		OTHER	R DOCUMENT(S)	Including Author	or, Title, Date, Pertin	nent Pages	s, Etc.)					
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